Acta Crystallographica Section C Crystal Structure Communications

ISSN 0108-2701

Gallium tris(iodate), Ga(IO₃)₃

Xue-An Chen,* Hai-Ping Xue, Xin-An Chang, He-Gui Zang and Wei-Qiang Xiao

College of Materials Science and Engineering, Beijing University of Technology, Ping Le Yuan 100, Beijing 100022, People's Republic of China Correspondence e-mail: xueanchen@bjut.edu.cn

Received 7 April 2005 Accepted 19 September 2005 Online 11 October 2005

Ga(IO₃)₃ crystallizes in the space group $P6_3$, with the Ga atom at a site with imposed threefold symmetry. The crystal structure consists of slightly distorted GaO₆ octahedra that are bridged by I atoms of IO₃⁻ groups, giving rise to a threedimensional polar network. The framework contains unoccupied hexagonal channels running parallel to the hexagonal [001] direction. The iodate groups have their stereochemically active non-bonded electron pairs pointing in the same direction along [001], which creates the polarity in the structure. The I–O bond distances and O–I–O angles are normal, being in the ranges 1.783 (3)–1.847 (2) Å and 94.68 (11)–99.61 (12)°, respectively.

Comment

Metal iodates have attracted much attention because some of these compounds exhibit piezoelectric and pyroelectric effects, and they have potential applications in second harmonic generation (SHG) (Morosin et al., 1973). The continued interest in these materials has led to the recent discovery of a series of new iodates, such as $AMoO_3(IO_3)$ (A = K, Rb and Cs; Sykora et al., 2002), Hg(IO₃)₂ (Bentria, Benbertal, Bagieu-Beucher, Mosset & Zaccaro, 2003) and Bi(IO₃)₃ (Bentria, Benbertal, Bagieu-Beucher, Masse & Mosset, 2003), among which $Hg(IO_3)_2$ and $AMoO_3(IO_3)$ (A = Rb and Cs) have been found to show large SHG responses. The title compound, $Ga(IO_3)_3$, was reported previously by Shklovskaya (1980), who only presented the powder X-ray diffraction patterns; its crystal structure remains as yet undetermined. In the course of our investigation of novel iodate non-linear optical (NLO) materials, we have obtained single crystals of $Ga(IO_3)_3$. The present X-ray structural analysis establishes that $Ga(IO_3)_3$ crystallizes in a polar and chiral space group, viz, P63, being a potential NLO material.

In the structure of $Ga(IO_3)_3$, the unique Ga^{3+} ion lies on a threefold axis and is coordinated to six O atoms in a slightly distorted octahedral geometry, the unique *trans* angle being 169.98 (10)° and the *cis* octahedral angles in the range 85.24 (10)–98.46 (10)° (Fig. 1 and Table 1). The Ga³⁺ ion shifts from the nominal center of its octahedron towards an octa-

hedral face by about 0.016 Å, resulting in three short Ga-O bonds [3 × 1.960 (2) Å], each of which is *trans* to a long Ga-O bond [1.980 (2) Å]. A similar coordination environment has been found for Ga³⁺ in Na_{1.98}Ga_{10.673}O₁₇, with Ga-O distances of 3 × 1.785 Å and 3 × 1.812 Å (Michiue *et al.*, 1991).

GaO₆ octahedra are arranged around 6₃ screw axes and bridged by I atoms of IO₃⁻ groups, leading to an overall three-dimensional framework, as shown in Fig. 2. Each IO₃⁻ group acts as a bidentate ligand bonded to two Ga³⁺ centers *via* two μ_2 -O atoms, with the third O atom kept 'dangling'. This form of ligation is common for IO₃⁻ groups, and was observed in VO₂IO₃·2H₂O (Meschede & Mattes, 1976) and Ce(IO₃)₄·H₂O (Ibers & Cromer, 1958). The I–O bond length for the 'dangling' O atoms [1.783 (3) Å] is slightly shorter than those for the O atoms bound to the Ga^{3+} centers [1.828 (2) and 1.847(2) Å] and both are very close to those generally found for iodate structures, for example, 1.80 (1)-1.84 (1) Å in $Hg(IO_3)_2$ and 1.790 (8)–1.828 (8) Å in $Bi(IO_3)_3$ (Bentria, Benbertal, Bagieu-Beucher, Mosset & Zaccaro, 2003; Bentria, Benbertal, Bagieu-Beucher, Masse & Mosset, 2003). The O-I-O bond angles are normal, being in the range 94.68 (11)-99.61 (12)°. The pyramidal iodate groups are arranged in such a way that the 'dangling' O atoms form an octahedral hole with a 4.490 (4) Å distance between *trans* O atoms. These holes are connected together to form one-dimensional open channels running parallel to the hexagonal [001] direction, and they are big enough to accommodate interstitial ions, such as Li⁺. However, our difference Fourier analyses did not reveal any significant electron-density peaks within these hexagonal tunnels. The refined structural model was further supported by bond-valence-sum (BVS) calculations (Brown & Altermatt, 1985), which produced reasonable values of 3.13 for Ga and 4.94 for I atoms.

Bi(IO₃)₃ is related to Ga(IO₃)₃ in stoichiometry but differs in the structure. In the former compound, each Bi³⁺ ion is coordinated by nine O atoms, forming a highly distorted monocapped square antiprism. The BiO₉ polyhedra are edgeconnected to form zigzag chains extending along the *b* axis; these chains are linked through IO₃⁻ groups, forming layers parallel to (101). The layers are held together *via* long I···O contacts, resulting in a three-dimensional framework. It is the variation in the coordination environments around the metal



Figure 1

The local coordination geometries of Ga and I in $Ga(IO_3)_3$, with displacement ellipsoids drawn at the 50% probability level.



Figure 2

The crystal structure of $Ga(IO_3)_3$, projected along the hexagonal [001] direction, where single shaded circles and open circles are I and O atoms, respectively, and octahedral GaO_6 units are represent by polyhedra.

cations that is mainly responsible for a structure change from $Ga(IO_3)_3$ to $Bi(IO_3)_3$.

It is clear from Fig. 2 that the iodate groups in $Ga(IO_3)_3$ are all aligned along the polar *c* axis, which creates the polarity in the structure, and the compound may be a potential NLO material. To confirm this, SHG measurements were performed using a modified Kurtz–NLO system with a 1064 nm light source (Kurtz & Perry, 1968) on powder of the ground crystals. Generation of green light of 532 nm was clearly observed, further supporting the assignment of this structure in a noncentrosymmetric setting.

Experimental

The title compound was synthesized under mild hydrothermal conditions. The starting materials were all of analytical grade purity. Ga₂O₃ (0.046 g, 0.245 mmol), H₅IO₆ (0.334 g, 1.465 mmol), HNO₃ (0.5 ml) and water (2 ml) were sealed in an 15 ml Teflon-lined autoclave, heated at 443 K for one week, and then cooled slowly to room temperature. The product consisted of colorless hexagonal columnlike crystals, the largest having dimensions of $0.6 \times 0.6 \times 1.0$ mm, in a colorless mother liquor. The final pH of the reaction system was about 1.0. The crystals, in about 64% yield (based on Ga), were isolated by washing the reaction product with deionized water and anhydrous ethanol, followed by drying with anhydrous acetone. Powder X-ray diffraction analysis revealed that the product is the single phase of Ga(IO₃)₃, no lines due to impurity phases being observed. The synthesis of Ga(IO₃)₃ involved a complex redox process in which the I^{7+} ion in IO_4^- was reduced by water to I^{5+} in IO_3^{-} . This type of reaction has already been noted in the preparation of many other metal iodates (Hector et al., 2002). HNO₃ was found to enhance the solvation processes and crystal growth of the target material. A separate set of experiments was conducted, in which a mixture of Ga2O3, H5IO6 and water (1:6:454 ratio) was heated hydrothermally at 443 K for 7 d. The reaction resulted in a fine white powder of unreacted Ga_2O_3 , no crystals of $Ga(IO_3)_3$ being obtained.

Crystal data

Ga(IO₃)₃ $M_r = 594.42$ Hexagonal, $P6_3$ a = 9.0924 (5) Å c = 5.2862 (8) Å V = 378.47 (6) Å³ Z = 2 $D_x = 5.216$ Mg m⁻³ Mo $K\alpha$ radiation Cell parameters from 25 reflections $\theta = 20.1-22.2^{\circ}$ $\mu = 15.90 \text{ mm}^{-1}$ T = 290 KPrism, colorless $0.2 \times 0.1 \times 0.1 \text{ mm}$

Data collection

Rigaku AFC-7R diffractometer			
$2\theta - \omega$ scans			
Absorption correction: ψ scan			
(Kopfman & Huber, 1968)			
$T_{\min} = 0.150, T_{\max} = 0.210$			
2720 measured reflections			
913 independent reflections			
902 reflections with $I > 2\sigma(I)$			
Refinement			
Refinement on F^2			
$R[F^2 > 2\sigma(F^2)] = 0.016$			
$m P(F^2) = 0.027$			

 $wR(F^{2}) = 0.037$ S = 1.27913 reflections 41 parameters $w = 1/[\sigma^{2}(F_{o}^{2}) + (0.013P)^{2} + 0.3153P]$ where $P = (F_{o}^{2} + 2F_{o}^{2})/3$

Table 1

Selected geometric parameters (Å, °).

Ga1—O3 ⁱ Ga1—O1 11—O2	1.960 (2) 1.980 (2) 1.783 (3)	I1-O3 I1-O1	1.828 (2) 1.847 (2)
$\begin{array}{c} O3^{i}-Ga1-O3^{ii}\\ O3^{i}-Ga1-O1^{iii}\\ O3^{iv}-Ga1-O1^{iii}\\ O3^{ii}-Ga1-O1^{iii}\\ O1^{iii}-Ga1-O1^{v}\\ \end{array}$	86.28 (10)	02-11-03	96.61 (12)
	98.46 (10)	02-11-01	99.61 (12)
	85.24 (10)	03-11-01	94.68 (11)
	169.98 (10)	11-01-Ga1	130.58 (13)
	90.75 (11)	$11-03-Ga1^{vi}$	121.80 (12)

 $R_{\rm int}=0.033$

 $\begin{aligned} \theta_{\max} &= 32.5^{\circ} \\ h &= 0 \rightarrow 13 \\ k &= -13 \rightarrow 11 \\ l &= -7 \rightarrow 7 \\ 3 \text{ standard reflections} \end{aligned}$

every 150 reflections intensity decay: -0.9%

Extinction correction: SHELXL97

Extinction coefficient: 0.0907 (19)

Absolute structure: Flack (1983),

 $\begin{array}{l} (\Delta/\sigma)_{\rm max} = 0.001 \\ \Delta\rho_{\rm max} = 0.63 \ {\rm e} \ {\rm \AA}^{-3} \\ \Delta\rho_{\rm min} = -1.02 \ {\rm e} \ {\rm \AA}^{-3} \end{array}$

412 Friedel pairs

Flack parameter: 0.01 (2)

Symmetry codes: (i) $y, -x + y, z - \frac{1}{2}$; (ii) $-x + 1, -y + 1, z - \frac{1}{2}$; (iii) -x + y + 1, -x + 1, z; (iv) $x - y + 1, x, z - \frac{1}{2}$; (v) -y + 1, x - y, z; (vi) $-x + 1, -y + 1, z + \frac{1}{2}$.

Data collection: *Rigaku/AFC Diffractometer Control Software* (Rigaku, 1994); cell refinement: *Rigaku/AFC Diffractometer Control Software*; data reduction: *Rigaku/AFC Diffractometer Control Software*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *ATOMS* (Dowty, 1999).

Supplementary data for this paper are available from the IUCr electronic archives (Reference: EM1002). Services for accessing these data are described at the back of the journal.

References

- Bentria, B., Benbertal, D., Bagieu-Beucher, M., Masse, R. & Mosset, A. (2003). J. Chem. Crystallogr. 33, 867–873.
- Bentria, B., Benbertal, D., Bagieu-Beucher, M., Mosset, A. & Zaccaro, J. (2003). Solid State Sci. 5, 359–363.
- Brown, I. D. & Altermatt, D. (1985). Acta Cryst. B41, 244-247.
- Dowty, E. (1999). ATOMS. Version 5.0. Shape Software, 521 Hidden Valley Road, Kingsport, TN 37663, USA.
- Hector, A. L., Henderson, S. J., Levason, W. & Webster, M. (2002). Z. Anorg. Allg. Chem. 628, 198–202.
- Ibers, J. A. & Cromer, D. T. (1958). Acta Cryst. 11, 794-798.
- Kopfmann, G. & Huber, R. (1968). Acta Cryst. A24, 348-351.
- Kurtz, S. K. & Perry, T. T. (1968). J. Appl. Phys. 39, 3798-3805.
- Meschede, W. & Mattes, R. (1976). Z. Anorg. Allg. Chem. 420, 25-30.
- Michiue, Y., Watanabe, M. & Fujiki, Y. (1991). Acta Cryst. C47, 495-498.
- Morosin, B., Bergman, J. G. & Crane, G. R. (1973). Acta Cryst. B29, 1067-1072.
- Rigaku (1994). Rigaku/AFC Diffractometer Control Software. Rigaku Corporation, Tokyo, Japan.
- Sheldrick, G. M. (1997). SHELXS97 and SHELXL97. University of Göttingen, Germany.
- Shklovskaya, R. (1980). Russ. J. Inorg. Chem. (Engl. Transl.), 25, 618-622.

Sykora, R. E., Ok, K. M., Halasyamani, P. S. & Albrecht-Schmitt, T. E. (2002). J. Am. Chem. Soc. 124, 1951–1957.